

SMPS MOSFET

IRF5801PbF

HEXFET® Power MOSFET

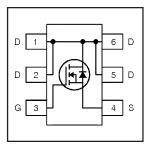
Applications

• High frequency DC-DC converters

V _{DSS}	R _{DS(on)} max	I _D
200V	2.2 Ω	0.6A

Benefits

- Low Gate to Drain Charge to Reduce Switching Losses
- Fully Characterized Capacitance Including Effective C_{OSS} to Simplify Design, (See App. Note AN1001)
- Fully Characterized Avalanche Voltage and Current
- Lead-Free
- Halogen-Free





Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V	0.6	
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ 10V	0.48	A
I _{DM}	Pulsed Drain Current ①	4.8	
P _D @T _A = 25°C	Power Dissipation	2.0	W
	Linear Derating Factor	0.016	W/°C
V _{GS}	Gate-to-Source Voltage	± 30	V
dv/dt	Peak Diode Recovery dv/dt ©	9.6	V/ns
T _J	Operating Junction and	-55 to + 150	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient @		62.5	°C/W

International **IOR** Rectifier

Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	200			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.26		V/°C	Reference to 25°C, I _D = 1mA ③
R _{DS(on)}	Static Drain-to-Source On-Resistance			2.2	Ω	V _{GS} = 10V, I _D = 0.36A ③
V _{GS(th)}	Gate Threshold Voltage	3.0		5.5	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
I _{DSS}	Drain-to-Source Leakage Current			25	μΑ	$V_{DS} = 200V, V_{GS} = 0V$
צטי	Dialii-to-Source Leakage Current			250	μΛ	$V_{DS} = 160V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 30V$
	Gate-to-Source Reverse Leakage			-100	I IIA	$V_{GS} = -30V$

Dynamic @ $T_{.1} = 25^{\circ}C$ (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
g _{fs}	Forward Transconductance	0.44			S	$V_{DS} = 50V, I_{D} = 0.36A$
Qg	Total Gate Charge		3.9			$I_D = 0.36A$
Q _{gs}	Gate-to-Source Charge		0.8		nC	$V_{DS} = 160V$
Q _{gd}	Gate-to-Drain ("Miller") Charge		2.2		Ī	$V_{GS} = 10V$
t _{d(on)}	Turn-On Delay Time		6.5			V _{DD} = 100V
t _r	Rise Time		8.0		ns	$I_D = 0.36A$
t _{d(off)}	Turn-Off Delay Time		8.8			$R_G = 53\Omega$
tf	Fall Time		19			V _{GS} = 10V ③
C _{iss}	Input Capacitance		88			$V_{GS} = 0V$
Coss	Output Capacitance		18			$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		6.3		pF	f = 1.0MHz
Coss	Output Capacitance		102		1	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
Coss	Output Capacitance		8.4]	$V_{GS} = 0V, V_{DS} = 160V, f = 1.0MHz$
C _{oss} eff.	Effective Output Capacitance		26]	V _{GS} = 0V, V _{DS} = 0V to 160V ⑤

Avalanche Characteristics

	Parameter	Тур.	Max.	Units
E _{AS}	Single Pulse Avalanche Energy®		9.9	mJ
I _{AR}	Avalanche Current①		0.6	Α

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			1.8		MOSFET symbol
	(Body Diode)			1.0	Α	showing the
I _{SM}	Pulsed Source Current			4.8		integral reverse
	(Body Diode) ①					p-n junction diode.
V _{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$, $I_S = 0.36A$, $V_{GS} = 0V$ ③
t _{rr}	Reverse Recovery Time		45		ns	$T_J = 25^{\circ}C, I_F = 0.36A$
Q _{rr}	Reverse RecoveryCharge		54		nC	di/dt = 100A/µs ③

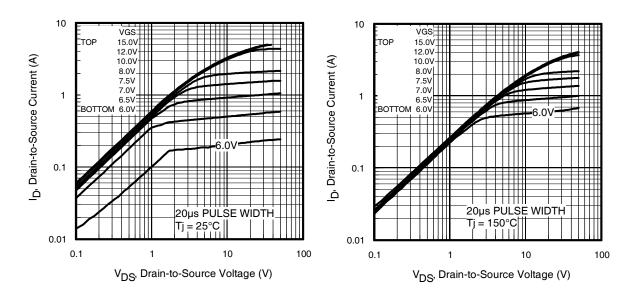


Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics

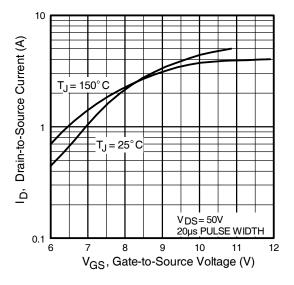


Fig 3. Typical Transfer Characteristics

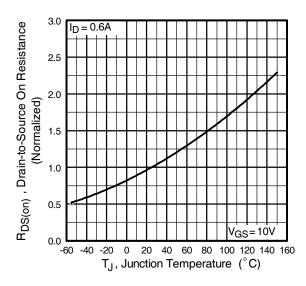


Fig 4. Normalized On-Resistance Vs. Temperature

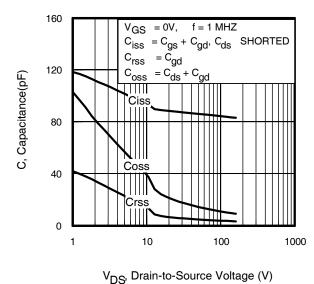


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

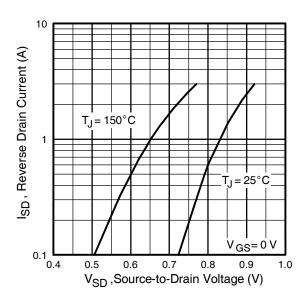


Fig 7. Typical Source-Drain Diode Forward Voltage

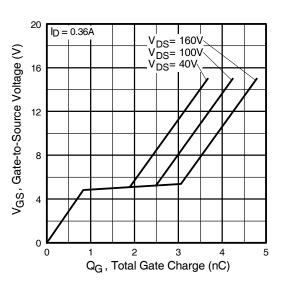


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

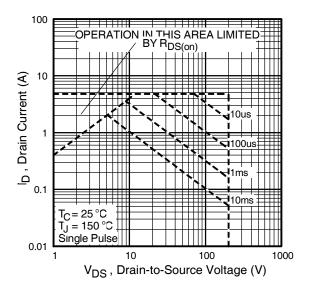


Fig 8. Maximum Safe Operating Area

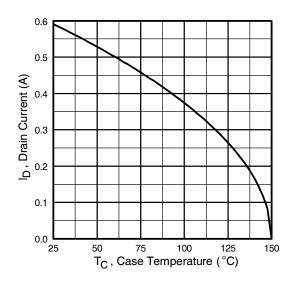


Fig 9. Maximum Drain Current Vs. Case Temperature

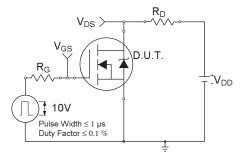


Fig 10a. Switching Time Test Circuit

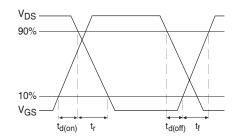


Fig 10b. Switching Time Waveforms

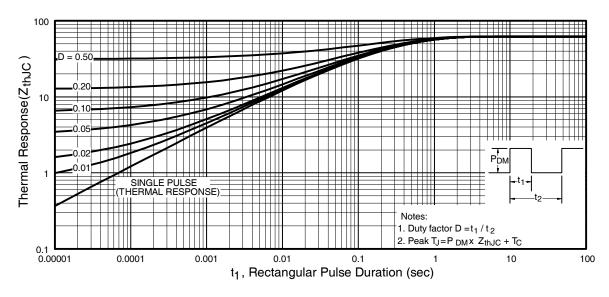
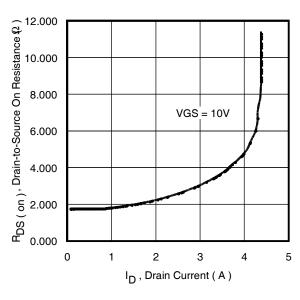


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



2.500 2.250 V_{GS}, Gate -to -Source Voltage (V)

Fig 12. On-Resistance Vs. Drain Current

Fig 13. On-Resistance Vs. Gate Voltage

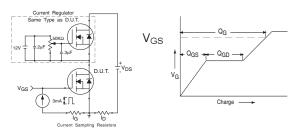
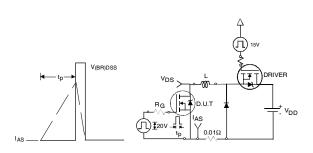


Fig 14a&b. Basic Gate Charge Test Circuit and Waveform



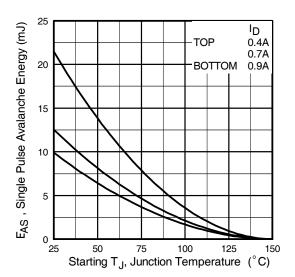
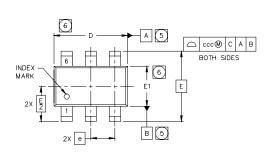


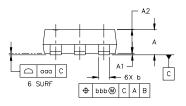
Fig 15a&b. Unclamped Inductive Test circuit and Waveforms

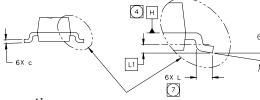
Fig 15c. Maximum Avalanche Energy Vs. Drain Current

TSOP-6 Package Outline



SYMBO	MO-193AA DIMENSIONS						
B	N.	/ILLIMETER	S	INCHES			
ĭ	MIN	NOM	MAX	MIN	МОМ	MAX	
Α			1,10			.0433	
A1	0,01		0,10	,0004		.0039	
A2	0.80	0.90	1.00	.0315	.0354	.0393	
ь	0.25		0.50	.0099		.0196	
С	0.10		0.26	.004		.010	
D	2.90	3.00	3.10	.115	.118	.122	
E		2.75 BSC		.108 BSC			
E1	1.30	1.50	1.70	.052	.059	.066	
е		1.00 BSC			.039 BSC		
L	0.20	0.40	0.60	.0079	.0157	.0236	
L1		0.30 BSC			.0118 BSC		
Θ	0,		8.	0.		8.	
aaa	0,10				.004		
bbb	0.15			.006			
ccc		0.25			.010		





TSOP-6 Part Marking Information

W = (1-26) IF PRECEDED BY LAST DIGIT OF CALENDAR YEAR

YEAR

WORK WEEK

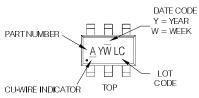
02 03

04

24 25

A B C

D



\Box \Box \Box \Box \Box Y = YEAR	2001
TNUMBER W = WEEK	2002
	2003
<u>A</u> YWLC	2004
	2005
/∃ ∃ ∃ ~ LOT	2006
WIRE INDICATOR TOP CODE	2007
WIRE INDICATOR 191	2008
	2009
	2010
AND THE MADED GODE DEFEDENCE	

PART NUMBER CODE REFERENCE:

K = IRF5810
L = IRF5804
M = IRF5803
N = IRF5802

-A line above the work week (as shown here) indicates Lead-Free -A line below the part number (as shown here) indicates Cu-wire

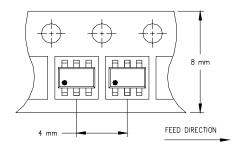
YEAR 2001 27 2002 29 30 2003 2004 2005 2006 2007 2008 2009 2010

W = (27-52) IF PRECEDED BY A LETTER

Note: For the most current drawing please refer to IR website at:	http://www.irf.com/package/
www.irf.com	

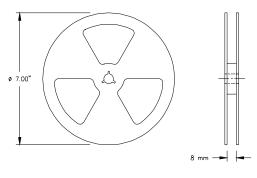
International IOR Rectifier

TSOP-6 Tape & Reel Information



NOTES:

1. OUTLINE CONFORMS TO EIA-481 & EIA-541.



1. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting $T_J = 25$ °C, L = 27mH $R_G=25\Omega,\ I_{AS}=0.36A.$
- 4 When mounted on 1 inch square copper board, t < 10sec.
- as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- $\textcircled{6} \ \ I_{SD} \leq 0.36 A, \ di/dt \leq 93 A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_{J} \leq 150^{\circ} C.$

Data and specifications subject to change without notice. This product has been designed and qualified for the Consumer market. Qualification Standards can be found on IR's Web site.



IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105 TAC Fax: (310) 252-7903

IMPORTANT NOTICE

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office (www.infineon.com).

WARNINGS

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.